



Teaching Teamwork: Measuring the Collaboration Skills Sought by Employers

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Teaching Teamwork What is this project about?

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- ✦ Not so much “teaching teamwork,” as **assessing** it.
- ✦ Not so much assessing content knowledge, as assessing **teamwork**.
- ✦ Tasks involving collaborative problem solving.
- ✦ Evaluating the contributions of individuals who are asked to solve a problem as a team.
- ✦ Can we identify the “team players,” the “leaders,” the “followers,” the “freeloaders,” the “saboteurs,” etc.?



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Today I'll Cover...

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- ✦ Background for project
- ✦ Description of project
- ✦ Timeline for project
- ✦ Different activities in this project
- ✦ Challenges/Findings of the project
- ✦ What's next?
- ✦ Demo activities



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Project Background

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- * **CAPA** (Computer-Assisted Performance Assessments, 2006-09). Developed **simulated** performance assessment tasks in introductory electronics, **logging** behaviors to provide evidence of student under-standing (better than paper/pencil test). **CAPA**
- * **SPARKS** (Simulated Performance Assessments for Related Knowledge and Skills, 2009-12). Encouraged **learning** by feedback to students and teachers obtained by automatically interpreting logs and assessments with repeated simulated activities. **SPARKS**
- * **TT** (Teaching Teamwork, 2014-17). Using simulated hands-on-lab assessments to collect, analyze, and quantify evidence and effects of **collaboration** by students.

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Our Team

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- * **Concord Consortium**
Concord, MA 
- * **Center for Occupational Research and Development**
Waco, TX 
- * **TCC**
Virginia Beach, VA 
- * **Educational Testing Service**
Princeton, NJ 

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TT Project Description

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- * NSF-funded project: July 2015 – June 2017 → June 2018
- * **Goals:** Seek ways to measure, encourage, and facilitate collaboration among students engaged in simulated hands-on skills.
- * Web-based software connects students in diverse locations to solve simulated but realistic problems. This project used a *basic electronics scenario*.
- * Computer “looks over students’ shoulders,” logs every action and chat exchanges, saved on central server.
- * We are still refining the semi-automatic analysis of the voluminous logged data.



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Project Timeline

★ **Year 1:** Develop Activity 1, pilot test, revise, initial analysis and interpretation of logged data.

★ **Revised** ★

★ **Year 2:** Revise Activity 1 to improve **data logging and interpretation**. (Work on Activity 2 and 3 delayed.)

★ **Year 3:** Develop Activity 2, and Activity 3, including improved data logging and analysis.

★ **Year 4:** Field test Activity 2, and possibly Activity 3. Automate analysis, final report.

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Project Activity 1

Series-resistance problem.

★ **Given:** A battery and four resistors in series; DMM.

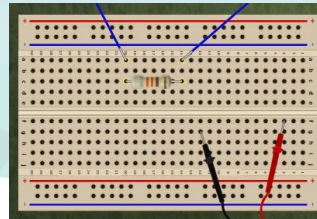
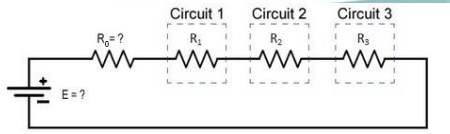
★ Each student can manipulate DMM and their **one R_i** and connections on a breadboard.

★ E, R_0 are “external.” Can’t be measured.

★ On-screen calculator and chat window.

★ **Goal:** Collaborate to obtain specified voltages across $R_1, R_2, \& R_3$.

★ We log **every student action and chat**.



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Project Activity 1



The Concord Consortium

Teaching Teamwork

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Project Activity 2

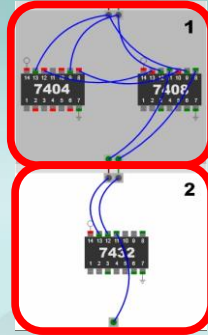
Elementary logic gates (AND, OR, NOT)

* Gates must be connected to perform specified functions, e.g. XOR or “adder”.

For example:

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- * **Student 1:** Connects NOT and AND gates to provide input for Student 2.
- * **Student 2:** Using inputs from Student 1, connects OR gates to achieve specified output states.
- * We log **every student action and chat** as they solve the problem.



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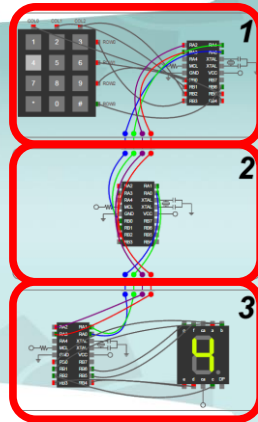
Project Activity 2

Microcontrollers: Keypad→Display

* 10-digit keypad must light 7-segment LED digit via three microcontrollers.

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- * **Student 1:** Connect keypad to microcontroller that yields a value for key-press row/column.
- * **Student 2:** Connect the key-press row-column value to microcontroller yielding a binary value.
- * **Student 3:** Connects the binary value to microcontroller to light proper segments for the digit.
- * We log **every student action and chat**.



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Project Challenges

- * Realistic simulations and user interface
- * Log everything possible, and manage the data
 - Student actions: mouse click, mouse drag
 - Value changes (e.g., resistance)
 - Chat text (by whom, when, to whom, info?)
 - Calculator actions
 - Confidentiality (no names, unique identities)
- * Data
 - Granularity: millisecond → LOTS of data!
 - Reliably store, identify, interpret each bit of data
 - Identify students, teams, pre- & post survey knowledge.

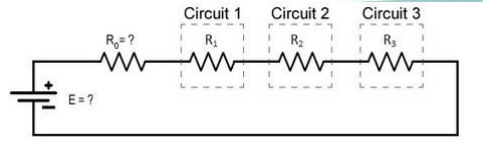


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Activity 1: Three-resistors Four Levels of Difficulty



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← Difficulty

Level	E value	R_0 value	Goal V_i
A	Given	Given	$V_1 = V_2 = V_3$
B	Given	Given	All goals diff
C	Must find E	Given	All goals diff
D	Must find E	Must find R_0	All goals diff

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Introductory Video

Teaching Teamwork
Introduction to Our
Simulated Circuit

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We Got It!

- ✳ When the group has achieved each of their goal voltages, one of them can click the 'We got it!' button!
- ✳ Each member receives the congratulations.
- ✳ They are ready to move on to **the next (harder) level!**
- ✳ Students learn (hopefully!) that achieving the goals requires **communication** and **cooperation**.
- ✳ How well did they communicate and cooperate?

All Goals Are Correct!

Circuit	Goal	Goal Value	Measured Value	Correct
1	Voltage across R1	1.67V	1.67V	Yes
2	Voltage across R2	4.35V	4.35V	Yes
3	Voltage across R3	3.06V	3.06V	Yes

[Move To Level 4](#)

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What We Are Learning

- ✦ Even simple tasks can be challenging—especially when collaboration is required.
- ✦ Orientation video reduces User Interface (UI) confusion that “muddies” good data and allows faster progress.
- 16 ✦ Students gain confidence and familiarity with one another as they proceed to increasing levels of difficulty.
- ✦ Students benefit from a “big picture view,” but not provide info (e.g., DMM display) that should be obtained via chat.
- ✦ Analyzing chat data is hard, but not impossible.
- ✦ Details of task **ontologies** will facilitate analysis (“next project”).

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What We Are Learning

- ✦ **Most surprising finding...**
 - ✦ Students are SMARTER than we think!
 - ✦ Some solved the hardest level in a **few seconds**, with NO chatting (i.e., no collaboration).
- 17 ✦ Surprise! They were solving the problem **like a video game!** Everyone changed their resistor sliders until they got it! Each behaving like a “voltage regulator!”
- ✦ **Fixed:** a) Replace “slider” with “pick list.” and b) Require entry of E and R0 values.



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Examining the Logfile

- ✦ Raw log files contain LOTS of information!
 - ✦ User and group info, activity level, time of entry
 - ✦ Event type (changed circuit, attached probe, detached probe, DMM measurement, DMM knob change, sent message, etc.)
 - ✦ Event values (message text, each circuit's voltage, resistance, DMM setting, DMM display value, probe location, etc.)

Time	User	Group	Activity	Value 1	Value 2	Value 3	Value 4	Value 5	Value 6	Value 7	Value 8	Value 9	Value 10
12:00	153h00s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:01	153h01s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:02	153h02s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:03	153h03s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:04	153h04s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:05	153h05s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:06	153h06s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:07	153h07s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:08	153h08s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:09	153h09s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:10	153h10s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:11	153h11s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:12	153h12s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:13	153h13s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:14	153h14s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:15	153h15s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:16	153h16s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:17	153h17s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:18	153h18s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:19	153h19s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:20	153h20s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:21	153h21s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:22	153h22s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:23	153h23s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:24	153h24s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:25	153h25s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:26	153h26s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:27	153h27s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:28	153h28s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:29	153h29s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000
12:30	153h30s	T	Changed circuit	1000	1000	1000	1000	1000	1000	1000	1000	1000	1000

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Examining the Logfile

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- ✦ Closer analysis reveals some emerging patterns.
- ✦ Messages exchanged via chat window
- ✦ Measurements made with DMM
- ✦ Changes to the circuit (R-values, lifting of wires)

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Additional Student Info

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- ✦ **Pre-surveys**
 - **Personal information:** *username*, age, sex, race, native language, % spoken at home, school, mother's education, books at home, number of siblings, several personality traits rating, etc.
 - **Reading the Mind in the Eyes** test
Estimating "social intelligence."
Hateful?
Jealous?
Arrogant?
Panicked?



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Additional Student Info

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- ✦ **Post-survey**
 - *username, team name*
 - What is Ohm's law?
 - Solve some related electronics problems:
 - ◆ R₁-R₂ in series
 - ◆ R₁-R₂-R₃ in series
 - ◆ R₁-R₂-R₃ in parallel, etc.
 - Reactions to today's simulation, collaboration, teammates, etc.

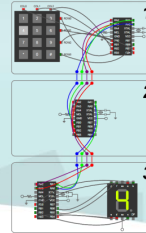
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Next Steps...

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- ✦ We collect student data and debugging **Activity 2**.
- ✦ **Activity 3** is ~ 80% complete.
- ✦ Data analysis engine is undergoing revision, driven by the “next project.”
- ✦ Seeking **Pilot Sites for Fall 2017 and Spring 2018** for Activity 2 and Activity 3:
 - ✦ “Intro Digital Logic” classes
 - ✦ “Intro Microprocessors” classes



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The Project Continues

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- ✦ Year 4 Extension: finish developments, field test
- ✦ Collecting and analyzing the voluminous log data.
- ✦ ...from three very different activities!
- ✦ Passing the baton to ETS for their NSF Project!
- ✦ If you wish to know more about this project, and/or wish to be a pilot site and contribute data from your students, please contact:

John Chamberlain, CORD
chamber@cord.org

concord.org/projects/teaching-teamwork

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